## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): MAKINO et al.

Atty. Dkt.: 11-231

Serial No.: Unknown

Group Art Unit:

Filed: Concurrently herewith

Examiner:

Title: SWITCHED-CAPACITOR LOW-

PASS FILTER AND

SEMICONDUCTOR PRESSURE

SENSOR APPARATUS

INCORPORATING THE FILTER

Date: March 4, 2004

Commissioner for Patents Arlington, VA 22202

## INFORMATION DISCLOSURE STATEMENT

Sir:

Pursuant to 37 C.F.R. §1.56, the reference(s) listed on the attached Form PTO-1449 is/are submitted for consideration by the Examiner without any admission that it/they constitute(s) statutory prior art, or without any admission that it/they contain(s) subject matter that anticipates the invention or renders the invention obvious to a person of ordinary skill in the art.

The Examiner is requested to initial the attached PTO Form-1449 and to return a copy of same to the undersigned attorney as proof that the listed reference(s) has/have been considered and made of record.

Respectfully submitted,

David G. Posz Reg. No. 37,701

Posz & Bethards, PLC 11250 Roger Bacon Drive, Suite 10 Reston, VA 20190 (703)707-9110 (phone) Customer No. 23400

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Form PTO-1449	ATTORNEY DOCKET NO. SERIAL NO.		
PATENT AND TRADEMARK OFFICE	->3		
INFORMATION DISCLOSURE CITATION	APPLICANT .	-	
(Use several sheets if necessary)	Takanori MAKINO et al.		
Sheet 1 of <u>1</u>	FILING DATE GROUP		
	March 4,2004	-	

U.S.PATENT DOCUMENTS						
Ref.	Examiner's	Document			Class/	(If appropriate)
Desig,	Initials	Number	Date	Name	Subclass	Filing Date
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FOREIGN PATENT DOCUMENTS							
					English Abstract		
Ref.	Examiner's	Document			Class/		
Desig,	Initials	Number	Date	Country	Subclass	Yes	No
		63-219219	9/12/88	Japan		Х	
		9-27731	1/28/97	Japan		Х	
		9-199994	7/31/97	Japan		х	
		2001-165797	6/22/01	Japan		Х	
		2002-39888	2/6/02	Japan		х	
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OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc. )						
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EXAMINER:		Date Co	onsidered:	